

# ANTREX Electronics

Electronic Components Sourcing Information

---

## Product Reference Information

|                      |                                     |
|----------------------|-------------------------------------|
| <b>Part Number:</b>  | TLV5633CDW                          |
| <b>Manufacturer:</b> | Texas Instruments                   |
| <b>Package:</b>      | 20-SOIC (0.295&quot;, 7.50mm Width) |
| <b>Availability:</b> | Please confirm with sales           |

### Product Page:

<https://antrexco.com/product/details/texas-instruments/tlv5633cdw.html>

### Request a Quote:

[Submit RFQ for this part](#)



Scan for product page

## Contact Information

Email: [info@antrexco.com](mailto:info@antrexco.com)

WhatsApp: +86-186-8066-5326

Website: <https://antrexco.com>

## Quality & Trust

New & Original Components

Supplier verification and packaging condition review

CoC / RoHS / REACH documents available on request

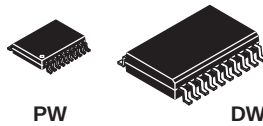
Secure sourcing support for OEM / EMS projects

### Note:

This PDF includes an ANTREX product reference cover page.

The original manufacturer datasheet follows from the next page.

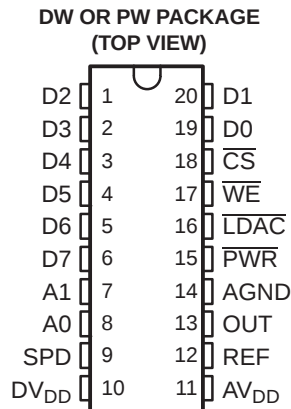
---



## 2.7 V TO 5.5 V LOW POWER 12-BIT DIGITAL-TO-ANALOG CONVERTERS WITH INTERNAL REFERENCE AND POWER DOWN

### FEATURES

- 12-Bit Voltage Output DAC
- Programmable Internal Reference
- Programmable Settling Time vs Power Consumption
  - 1  $\mu$ s in Fast Mode
  - 3.5  $\mu$ s in Slow Mode
- 8-Bit  $\mu$ Controller Compatible Interface
- Differential Nonlinearity . . . <0.5 LSB Typ
- Voltage Output Range . . . 2x the Reference Voltage
- Monotonic Over Temperature



### APPLICATIONS

- Digital Servo Control Loops
- Digital Offset and Gain Adjustment
- Industrial Process Control
- Machine and Motion Control Devices
- Mass Storage Devices

### DESCRIPTION

The TLV5633 is a 12-bit voltage output digital- to-analog converter (DAC) with an 8-bit microcontroller compatible parallel interface. The 8 LSBs, the 4 MSBs, and 5 control bits are written using three different addresses. Developed for a wide range of supply voltages, the TLV5633 can be operated from 2.7 V to 5.5 V.

The resistor string output voltage is buffered by a x2 gain rail-to-rail output buffer. The buffer features a Class A (slow mode: AB) output stage to improve stability and reduce settling time. The programmable settling time of the DAC allows the designer to optimize speed versus power dissipation. With its on-chip programmable precision voltage reference, the TLV5633 simplifies overall system design. Because of its ability to source up to 1 mA, the internal reference can also be used as a system reference. The settling time and the reference voltage can be chosen by a control register.

Implemented with a CMOS process, the device is designed for single supply operation from 2.7 V to 5.5 V. It is available in 20-pin SOIC and TSSOP packages in standard commercial and industrial temperature ranges.

### AVAILABLE OPTIONS

| T <sub>A</sub> | PACKAGE <sup>(1)</sup> |            |
|----------------|------------------------|------------|
|                | SOIC (DW)              | TSSOP (PW) |
| 0°C to 70°C    | TLV5633CDW             | TLV5633CPW |
| -40°C to 85°C  | TLV5633IDW             | TLV5633IPW |

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI Web site at [www.ti.com](http://www.ti.com).



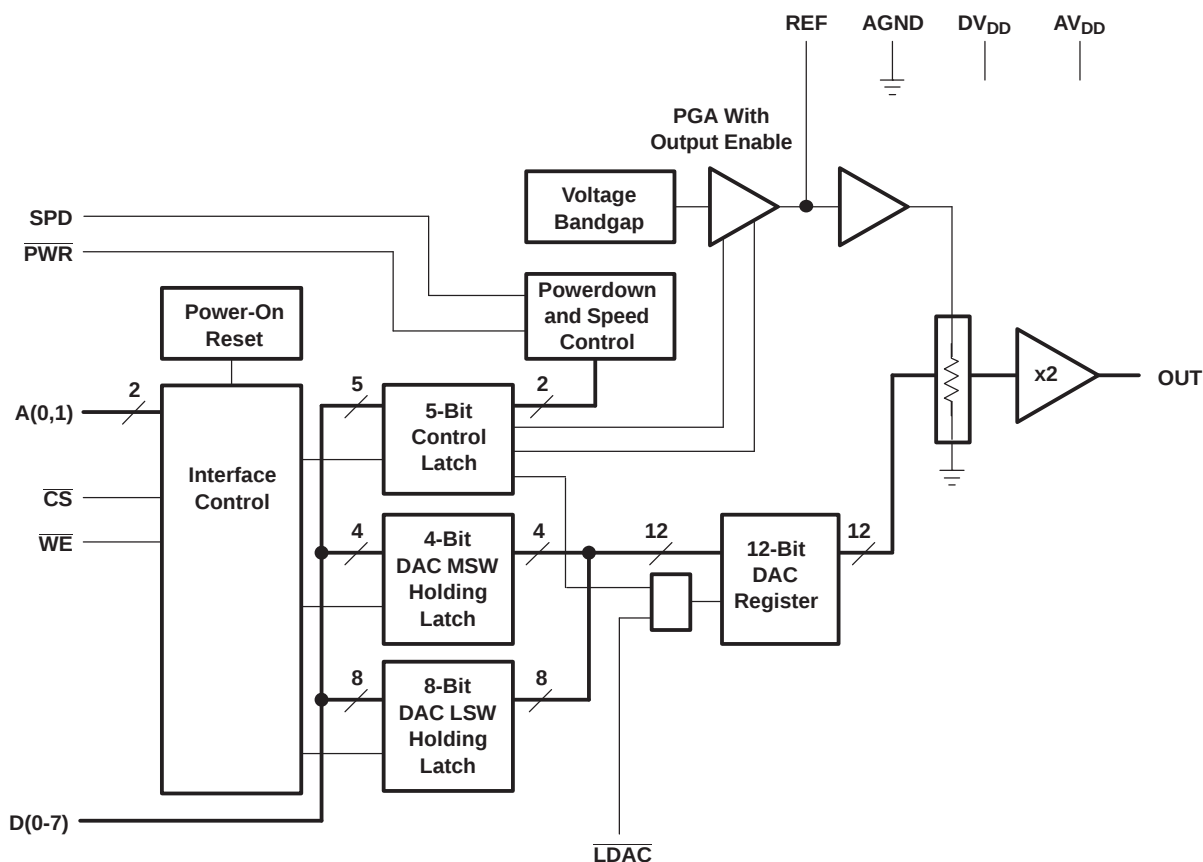
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

MCS is a registered trademark of Intel Corporation .



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## FUNCTIONAL BLOCK DIAGRAM



## Terminal Functions

| TERMINAL<br>NAME  | NO.    | I/O/P | DESCRIPTION                                                          |
|-------------------|--------|-------|----------------------------------------------------------------------|
| A1, A0            | 7, 8   | I     | Address input                                                        |
| AGND              | 14     | P     | Ground                                                               |
| AV <sub>DD</sub>  | 11     | P     | Positive power supply (analog part)                                  |
| $\overline{CS}$   | 18     | I     | Chip select. Digital input active low, used to enable/disable inputs |
| D0-D1             | 19, 20 | I     | Data input                                                           |
| D2-D7             | 1-6    | I     | Data input                                                           |
| DV <sub>DD</sub>  | 10     | P     | Positive power supply (digital part)                                 |
| $\overline{LDAC}$ | 16     | I     | Load DAC. Digital input active low, used to load DAC output          |
| OUT               | 13     | O     | DAC analog voltage output                                            |
| $\overline{PWR}$  | 15     | I     | Power down. Digital input active low                                 |
| REF               | 12     | I/O   | Analog reference voltage input/output                                |
| SPD               | 9      | I     | Speed select. Digital input                                          |
| $\overline{WE}$   | 17     | I     | Write enable. Digital input active low, used to latch data           |

## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                                                                      |          | UNIT                              |
|----------------------------------------------------------------------|----------|-----------------------------------|
| Supply voltage (DV <sub>DD</sub> , AV <sub>DD</sub> to AGND)         |          | 7 V                               |
| Supply voltage difference range, AV <sub>DD</sub> - DV <sub>DD</sub> |          | -2.8 V to 2.8 V                   |
| Reference input voltage range                                        |          | -0.3 V to V <sub>DD</sub> + 0.3 V |
| Digital input voltage range                                          |          | -0.3 V to V <sub>DD</sub> + 0.3 V |
| Operating free-air temperature range, T <sub>A</sub>                 | TLV5633C | 0°C to 70°C                       |
|                                                                      | TLV5633I | -40°C to 85°C                     |
| Storage temperature range, T <sub>stg</sub>                          |          | -65°C to 150°C                    |

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## RECOMMENDED OPERATING CONDITIONS

|                                                                                 |                          | MIN  | NOM   | MAX                   | UNIT |
|---------------------------------------------------------------------------------|--------------------------|------|-------|-----------------------|------|
| Supply voltage, DV <sub>DD</sub> , AV <sub>DD</sub>                             | 5-V operation            | 4.5  | 5     | 5.5                   | V    |
|                                                                                 | 3-V operation            | 2.7  | 3     | 3.3                   | V    |
| Supply voltage difference, $\Delta V_{DD} = AV_{DD} - DV_{DD}$                  |                          | 0    | 0     | 0                     | V    |
| Power on reset voltage, POR                                                     |                          | 0.55 |       | 2                     | V    |
| High-level digital input voltage, V <sub>IH</sub>                               | DV <sub>DD</sub> = 2.7 V | 2    |       |                       | V    |
|                                                                                 | DV <sub>DD</sub> = 5.5 V | 2.4  |       |                       |      |
| Low-level digital input voltage, V <sub>IL</sub>                                | DV <sub>DD</sub> = 2.7 V |      |       | 0.6                   | V    |
|                                                                                 | DV <sub>DD</sub> = 5.5 V |      |       | 1                     |      |
| Reference voltage, V <sub>ref</sub> to REF terminal (5-V supply) <sup>(1)</sup> |                          | AGND | 2.048 | AV <sub>DD</sub> -1.5 | V    |
| Reference voltage, V <sub>ref</sub> to REF terminal (3-V supply) <sup>(1)</sup> |                          | AGND | 1.024 | AV <sub>DD</sub> -1.5 | V    |
| Load resistance, R <sub>L</sub>                                                 |                          | 2    |       |                       | kΩ   |
| Load capacitance, C <sub>L</sub>                                                |                          |      |       | 100                   | pF   |
| Operating free-air temperature, T <sub>A</sub>                                  | TLV5633C                 | 0    |       | 70                    | °C   |
|                                                                                 | TLV5633I                 | -40  |       | 85                    |      |

(1) Due to the x2 output buffer, a reference input voltage  $\geq AV_{DD}/2$  causes clipping of the transfer function. The output buffer of the internal reference must be disabled, if an external reference is used.

## ELECTRICAL CHARACTERISTICS

over recommended operating free-air temperature range,  $V_{ref} = 2.048\text{ V}$ ,  $V_{ref} = 1.024\text{ V}$  (unless otherwise noted)

| POWER SUPPLY                    |                                                              |                                                                          |                                                   |        |      |                       |      |                |      |
|---------------------------------|--------------------------------------------------------------|--------------------------------------------------------------------------|---------------------------------------------------|--------|------|-----------------------|------|----------------|------|
| PARAMETER                       |                                                              | TEST CONDITIONS                                                          |                                                   |        |      | MIN                   | TYP  | MAX            | UNIT |
| I <sub>DD</sub>                 | Power supply current                                         | No load,<br>All inputs = AGND or DV <sub>DD</sub> ,<br>DAC latch = 0x800 | AV <sub>DD</sub> = 5 V,<br>DV <sub>DD</sub> = 5 V | REF on | Fast | 2.3                   | 2.8  | mA             |      |
|                                 |                                                              |                                                                          |                                                   | REF on | Slow | 1.3                   | 1.6  | mA             |      |
|                                 |                                                              |                                                                          | REF off                                           | Fast   | 1.9  | 2.4                   | mA   |                |      |
|                                 |                                                              |                                                                          |                                                   | Slow   | 0.9  | 1.2                   | mA   |                |      |
|                                 |                                                              | AV <sub>DD</sub> = 3 V,<br>DV <sub>DD</sub> = 3 V                        | REF on                                            | Fast   | 2.1  | 2.6                   | mA   |                |      |
|                                 |                                                              |                                                                          |                                                   | Slow   | 1.2  | 1.5                   | mA   |                |      |
|                                 |                                                              |                                                                          | REF off                                           | Fast   | 1.8  | 2.3                   | mA   |                |      |
|                                 |                                                              |                                                                          |                                                   | Slow   | 0.9  | 1.1                   | mA   |                |      |
| Power down supply current       |                                                              |                                                                          |                                                   |        |      | 0.01                  | 1    | μA             |      |
| PSRR                            | Power supply rejection ratio                                 | Zero scale, external reference <sup>(1)</sup>                            |                                                   |        |      | -60                   |      | dB             |      |
|                                 |                                                              | Full scale, external reference <sup>(2)</sup>                            |                                                   |        |      | -60                   |      |                |      |
| STATIC DAC SPECIFICATIONS       |                                                              |                                                                          |                                                   |        |      |                       |      |                |      |
| Resolution                      |                                                              |                                                                          |                                                   |        |      | 12                    |      | bits           |      |
| INL                             | Integral nonlinearity, end point adjusted                    | R <sub>L</sub> = 10 kΩ, C <sub>L</sub> = 100 pF <sup>(3)</sup>           |                                                   |        |      | ±1.2                  | ±3   | LSB            |      |
| DNL                             | Differential nonlinearity                                    | R <sub>L</sub> = 10 kΩ, C <sub>L</sub> = 100 pF <sup>(4)</sup>           |                                                   |        |      | ±0.3                  | ±0.5 | LSB            |      |
| E <sub>ZS</sub>                 | Zero-scale error (offset error at zero scale) <sup>(5)</sup> |                                                                          |                                                   |        |      |                       | 20   | mV             |      |
| E <sub>ZS</sub> TC              | Zero-scale-error temperature coefficient <sup>(6)</sup>      |                                                                          |                                                   |        |      |                       | 20   | ppm/°C         |      |
| E <sub>G</sub>                  | Gain error <sup>(7)</sup>                                    |                                                                          |                                                   |        |      |                       | ±0.3 | % full scale V |      |
| E <sub>G</sub> TC               | Gain error temperature coefficient <sup>(8)</sup>            |                                                                          |                                                   |        |      | 20                    |      | ppm/°C         |      |
| OUTPUT SPECIFICATIONS           |                                                              |                                                                          |                                                   |        |      |                       |      |                |      |
| V <sub>O</sub>                  | Output voltage                                               | R <sub>L</sub> = 10 kΩ                                                   |                                                   |        |      | AV <sub>DD</sub> -0.4 |      | V              |      |
| Output load regulation accuracy |                                                              | V <sub>O</sub> = 4.096 V, 2.048 V, R <sub>L</sub> = 2 kΩ                 |                                                   |        |      | ±0.29                 |      | % full scale V |      |

(1) Power supply rejection ratio at zero scale is measured by varying  $AV_{DD}$  and is given by:  $\text{PSRR} = 20 \log [(E_{ZS}(AV_{DD\text{max}}) - E_{ZS}(AV_{DD\text{min}}))/AV_{DD\text{max}}]$

(2) Power supply rejection ratio at full scale is measured by varying  $AV_{DD}$  and is given by:  $\text{PSRR} = 20 \log [(E_G(AV_{DD\text{max}}) - E_G(AV_{DD\text{min}}))/AV_{DD\text{max}}]$

(3) The relative accuracy or integral nonlinearity (INL) sometimes referred to as linearity error, is the maximum deviation of the output from the line between zero and full scale excluding the effects of zero code and full-scale errors (see text).

(4) The differential nonlinearity (DNL) sometimes referred to as differential error, is the difference between the measured and ideal 1 LSB amplitude change of any two adjacent codes. Monotonic means the output voltage changes in the same direction (or remains constant) as a change in the digital input code.

(5) Zero-scale error is the deviation from zero voltage output when the digital input code is zero (see text).

(6) Zero-scale-error temperature coefficient is given by:  $E_{ZS\text{ TC}} = [E_{ZS}(T_{\text{max}}) - E_{ZS}(T_{\text{min}})]/2V_{ref} \times 10^6/(T_{\text{max}} - T_{\text{min}})$ .

(7) Gain error is the deviation from the ideal output ( $2V_{ref} - 1\text{ LSB}$ ) with an output load of  $10\text{ k}\Omega$  excluding the effects of the zero-error.

(8) Gain temperature coefficient is given by:  $E_G\text{ TC} = [E_G(T_{\text{max}}) - E_G(T_{\text{min}})]/2V_{ref} \times 10^6/(T_{\text{max}} - T_{\text{min}})$ .

## ELECTRICAL CHARACTERISTICS (continued)

over recommended operating free-air temperature range,  $V_{ref} = 2.048\text{ V}$ ,  $V_{ref} = 1.024\text{ V}$  (unless otherwise noted)

| REFERENCE PIN CONFIGURED AS OUTPUT (REF) |                              |                                     |  |       |       |       |
|------------------------------------------|------------------------------|-------------------------------------|--|-------|-------|-------|
| PARAMETER                                |                              | TEST CONDITIONS                     |  | MIN   | TYP   | MAX   |
| $V_{ref(OUTL)}$                          | Low reference voltage        |                                     |  | 1.003 | 1.024 | 1.045 |
| $V_{ref(OUTH)}$                          | High reference voltage       | $AV_{DD} = DV_{DD} > 4.75\text{ V}$ |  | 2.027 | 2.048 | 2.069 |
| $I_{ref(source)}$                        | Output source current        |                                     |  |       |       | 1     |
| $I_{ref(sink)}$                          | Output sink current          |                                     |  | -1    |       |       |
| PSRR                                     | Power supply rejection ratio |                                     |  |       | -48   |       |

| REFERENCE PIN CONFIGURED AS INPUT (REF) |                   |                                                                  |         |      |     |               |
|-----------------------------------------|-------------------|------------------------------------------------------------------|---------|------|-----|---------------|
| PARAMETER                               |                   | TEST CONDITIONS                                                  |         | MIN  | TYP | MAX           |
| $V_I$                                   | Input voltage     |                                                                  |         | 0    |     | $AV_{DD-1.5}$ |
| $R_I$                                   | Input resistance  |                                                                  |         |      | 10  |               |
| $C_I$                                   | Input capacitance |                                                                  |         |      | 5   |               |
| Reference input bandwidth               |                   | $REF = 0.2 V_{pp} + 1.024\text{ V dc}$                           | Fast    |      | 900 |               |
|                                         |                   |                                                                  | Slow    |      | 500 |               |
| Harmonic distortion, reference input    |                   | $REF = 1 V_{pp} + 2.048\text{ V dc}$ ,<br>$AV_{DD} = 5\text{ V}$ | 10 kHz  | Fast | -87 |               |
|                                         |                   |                                                                  | 10 kHz  | Slow | -77 |               |
|                                         |                   |                                                                  | 50 kHz  | Fast | -74 |               |
|                                         |                   |                                                                  | 50 kHz  | Slow | -61 |               |
|                                         |                   |                                                                  | 100 kHz | Fast | -66 |               |
|                                         |                   |                                                                  | 100 kHz | Slow | -66 |               |
| Reference feedthrough                   |                   | $REF = 1 V_{pp}$ at 1 kHz + 1.024 V dc <sup>(1)</sup>            |         |      | -80 |               |

### DIGITAL INPUTS

|          |                                  |                    |  |    |   |               |
|----------|----------------------------------|--------------------|--|----|---|---------------|
| $I_{IH}$ | High-level digital input current | $V_I = DV_{DD}$    |  | 1  |   | $\mu\text{A}$ |
| $I_{IL}$ | Low-level digital input current  | $V_I = 0\text{ V}$ |  | -1 |   | $\mu\text{A}$ |
| $C_I$    | Input capacitance                |                    |  |    | 8 | pF            |

(1) Reference feedthrough is measured at the DAC output with an input code = 0x000.

## OPERATING CHARACTERISTICS

over recommended operating free-air temperature range,  $V_{ref} = 2.048\text{ V}$ , and  $V_{ref} = 1.024\text{ V}$ , (unless otherwise noted)

| ANALOG OUTPUT DYNAMIC PERFORMANCE |                                    |                                                                                                                                  |      |     |     |     |      |     |
|-----------------------------------|------------------------------------|----------------------------------------------------------------------------------------------------------------------------------|------|-----|-----|-----|------|-----|
| PARAMETER                         |                                    | TEST CONDITIONS                                                                                                                  |      | MIN | TYP | MAX | UNIT |     |
| t <sub>s(FS)</sub>                | Output settling time, full scale   | R <sub>L</sub> = 10 kΩ, C <sub>L</sub> = 100 pF <sup>(1)</sup>                                                                   | Fast |     | 1   | 3   | μs   |     |
|                                   |                                    |                                                                                                                                  | Slow |     | 3.5 | 7   |      |     |
| t <sub>s(CC)</sub>                | Output settling time, code to code | R <sub>L</sub> = 10 kΩ, C <sub>L</sub> = 100 pF <sup>(2)</sup>                                                                   | Fast |     | 0.5 | 1.5 | μs   |     |
|                                   |                                    |                                                                                                                                  | Slow |     | 1   | 2   |      |     |
| SR                                | Slew rate                          | R <sub>L</sub> = 10 kΩ, C <sub>L</sub> = 100 pF <sup>(3)</sup>                                                                   | Fast |     | 6   | 10  | V/μs |     |
|                                   |                                    |                                                                                                                                  | Slow |     | 1.2 | 1.7 |      |     |
| Glitch energy                     |                                    | DIN = 0 to 1, f <sub>CLK</sub> = 100 kHz, $\overline{CS} = V_{DD}$                                                               |      |     | 5   |     | nV-S |     |
| SNR                               | Signal-to-noise ratio              | f <sub>s</sub> = 480 kSPS, f <sub>B</sub> = 20 kHz, f <sub>out</sub> = 1 kHz,<br>R <sub>L</sub> = 10 kΩ, C <sub>L</sub> = 100 pF |      |     | 73  | 78  | dB   |     |
| SINAD                             | Signal-to-noise + distortion       |                                                                                                                                  |      |     | 61  | 67  |      |     |
| THD                               | Total harmonic distortion          |                                                                                                                                  |      |     |     | -69 |      | -62 |
| SFDR                              | Spurious free dynamic range        |                                                                                                                                  |      |     | 63  | 74  |      |     |

- (1) Settling time is the time for the output signal to remain within  $\pm 0.5$  LSB of the final measured value for a digital input code change of 0x020 to 0xFDF or 0xFDF to 0x020 respectively.
- (2) Settling time is the time for the output signal to remain within  $\pm 0.5$  LSB of the final measured value for a digital input code change of one count.
- (3) Slew rate determines the time it takes for a change of the DAC output from 10% to 90% full-scale voltage.

## DIGITAL INPUT TIMING REQUIREMENTS

|                 |                                                                              | MIN | NOM | MAX | UNIT |
|-----------------|------------------------------------------------------------------------------|-----|-----|-----|------|
| $t_{su(CS-WE)}$ | Setup time, $\overline{CS}$ low before negative $\overline{WE}$ edge         | 15  |     |     | ns   |
| $t_{su(D)}$     | Setup time, data ready before positive $\overline{WE}$ edge                  | 10  |     |     | ns   |
| $t_{su(A)}$     | Setup time, addresses ready before positive $\overline{WE}$ edge             | 20  |     |     | ns   |
| $t_{h(DA)}$     | Hold time, data and addresses held valid after positive $\overline{WE}$ edge | 5   |     |     | ns   |
| $t_{su(WE-LD)}$ | Setup time, positive $\overline{WE}$ edge before $\overline{LDAC}$ low       | 5   |     |     | ns   |
| $t_{WH(WE)}$    | Pulse duration, $\overline{WE}$ high                                         | 20  |     |     | ns   |
| $t_{w(LD)}$     | Pulse duration, $\overline{LDAC}$ low                                        | 23  |     |     | ns   |

## PARAMETER MEASUREMENT INFORMATION

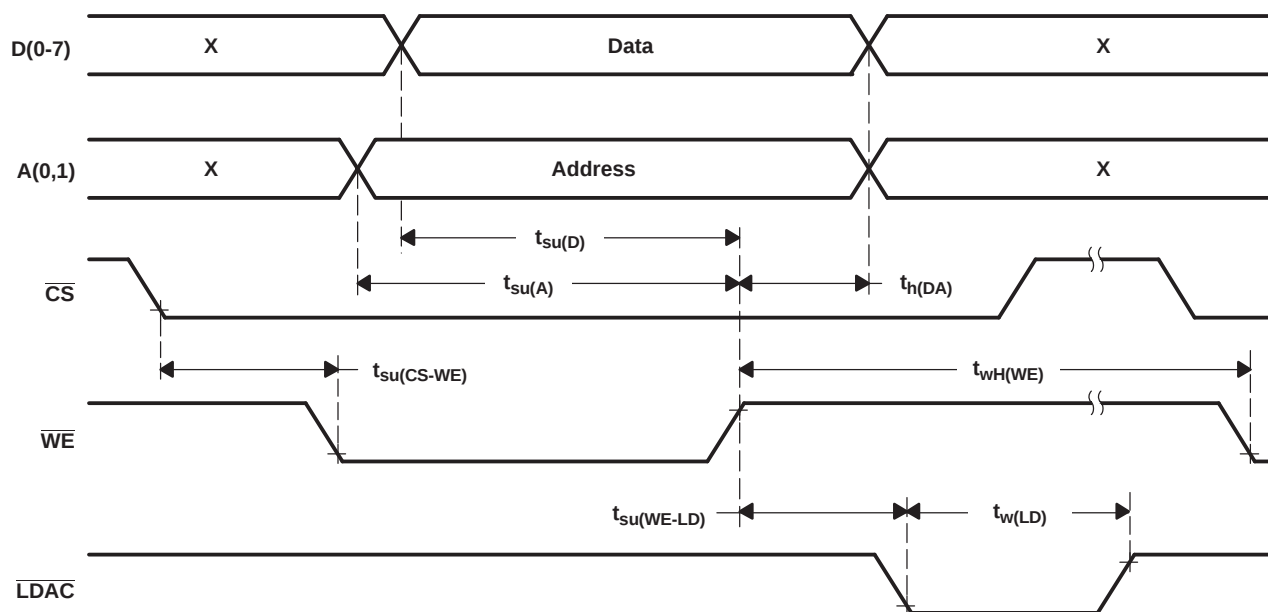


Figure 1. Timing Diagram

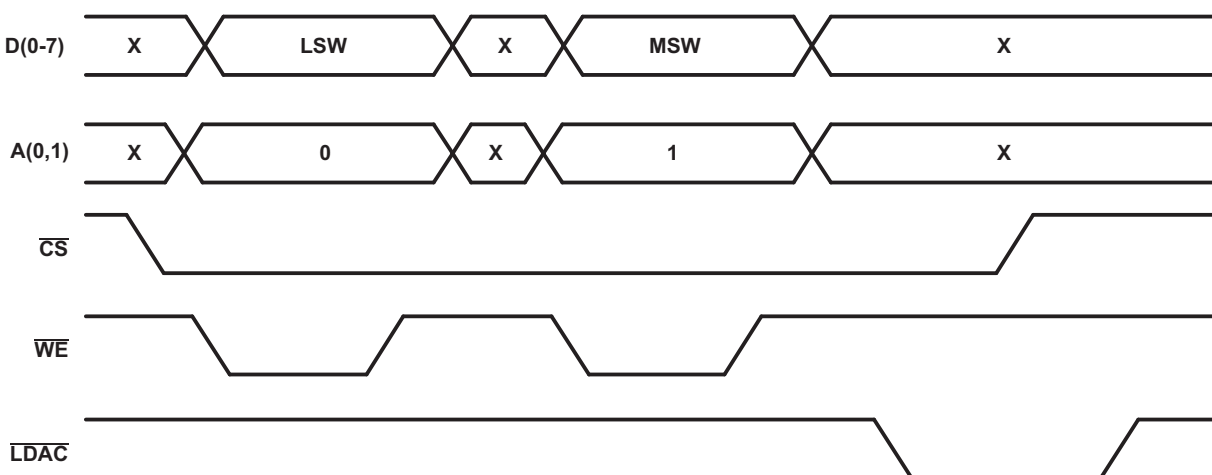


Figure 2. Example of a Complete Write Cycle (MSW, LSW) Using  $\overline{LDAC}$  for Update

### PARAMETER MEASUREMENT INFORMATION (continued)

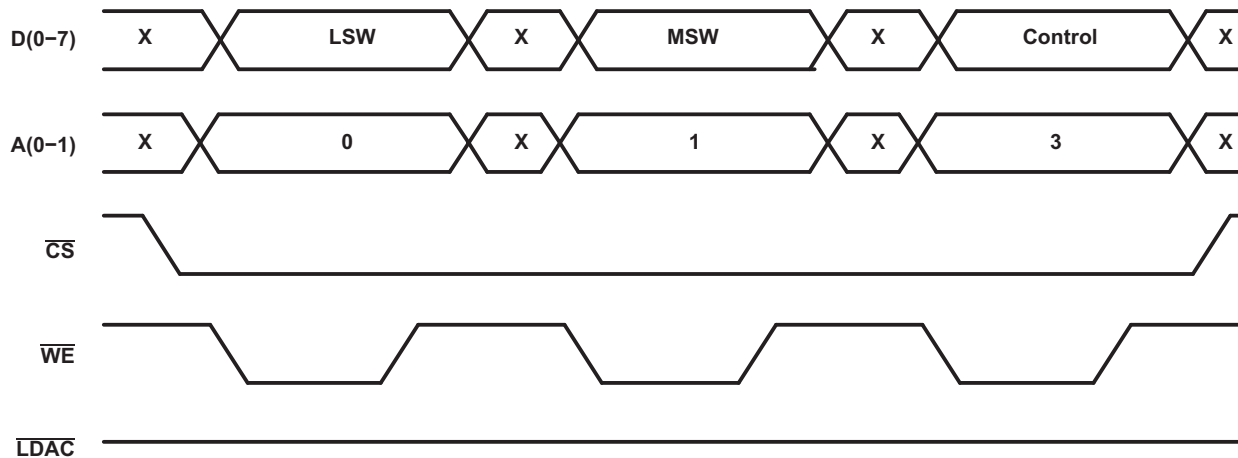


Figure 3. Example of a Complete Write Cycle (MSW, LSW, Control)

## TYPICAL CHARACTERISTICS

### DIFFERENTIAL NONLINEARITY ERROR

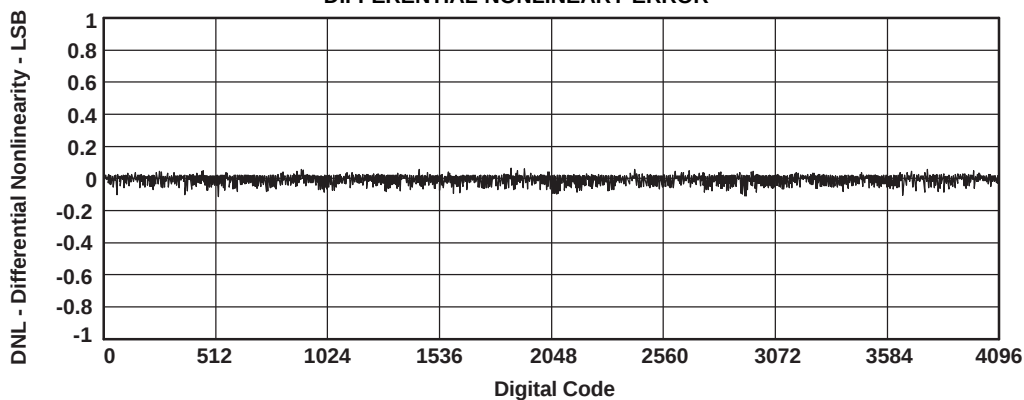


Figure 4.

### INTEGRAL NONLINEARITY ERROR

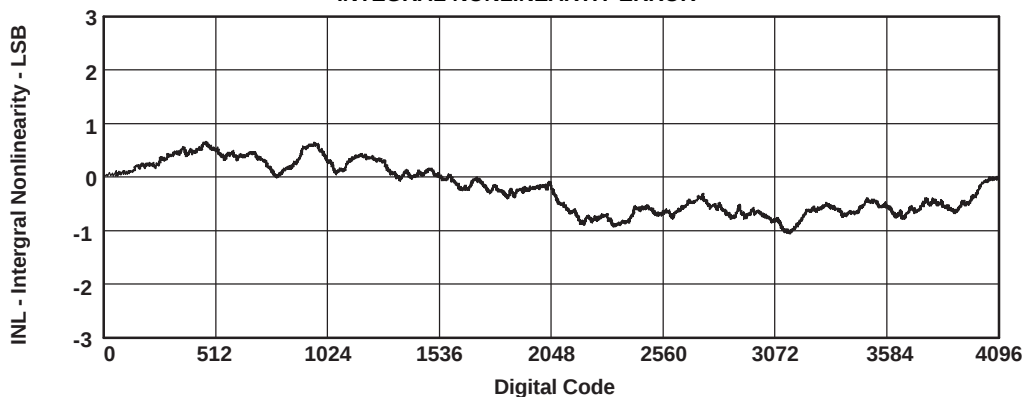


Figure 5.

### MAXIMUM OUTPUT VOLTAGE vs LOAD CURRENT

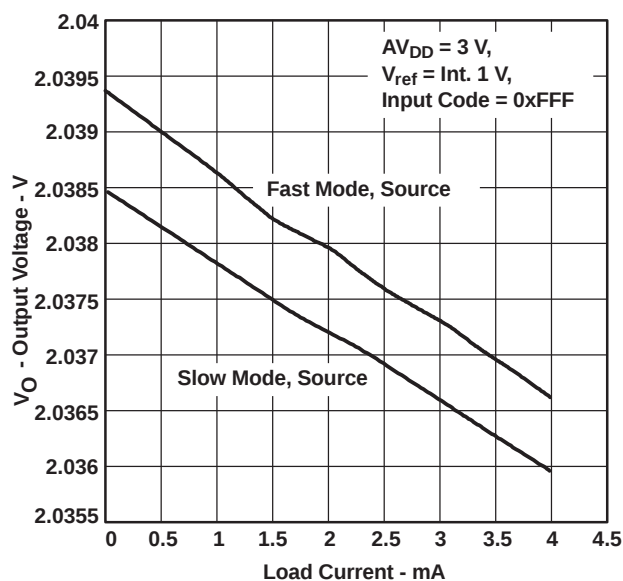


Figure 6.

### MAXIMUM OUTPUT VOLTAGE vs LOAD CURRENT

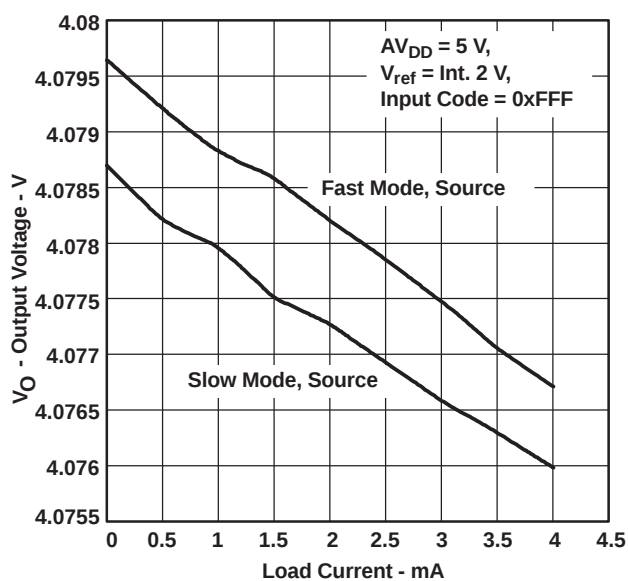


Figure 7.

## TYPICAL CHARACTERISTICS (continued)

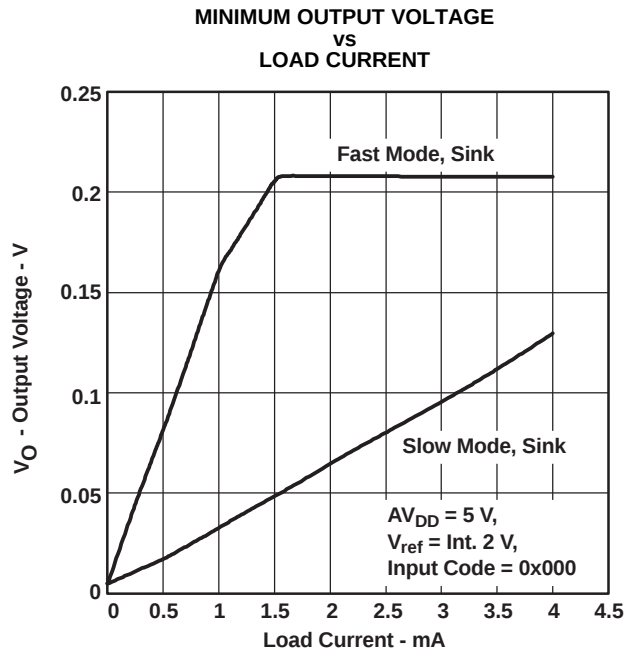


Figure 8.

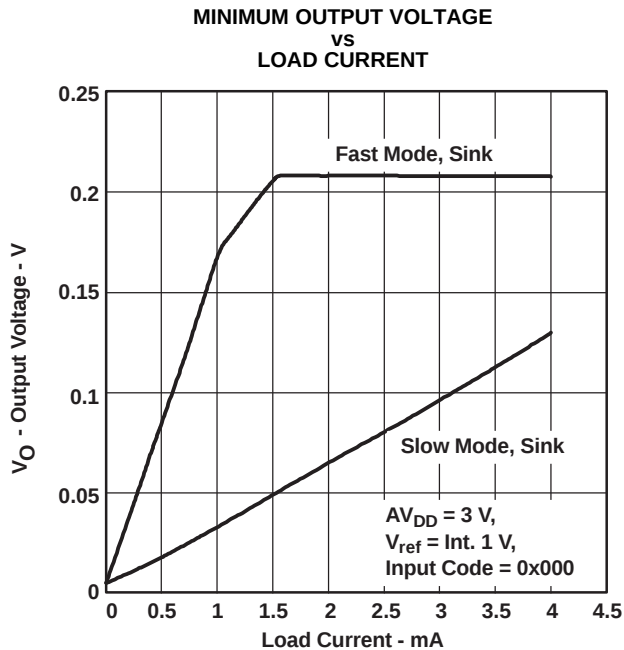


Figure 9.

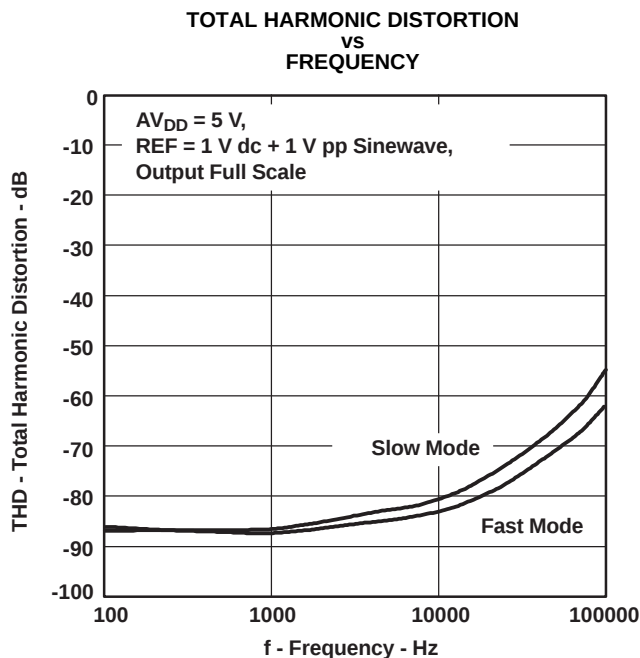


Figure 10.

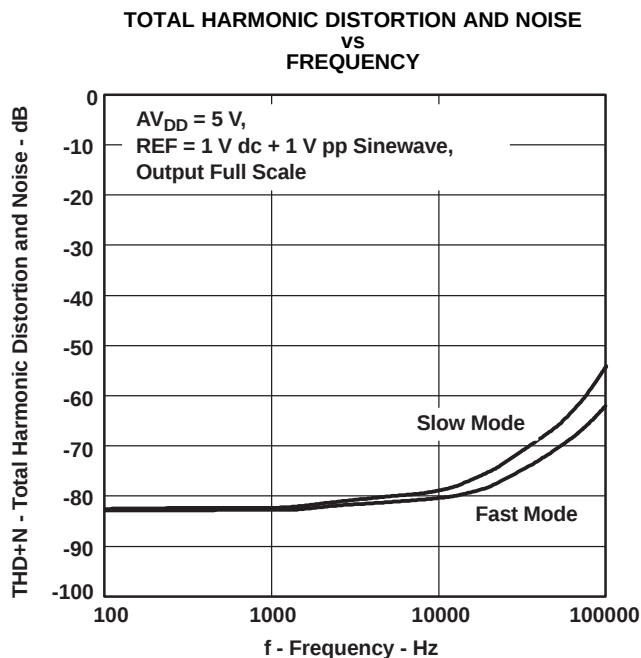


Figure 11.

## TYPICAL CHARACTERISTICS (continued)

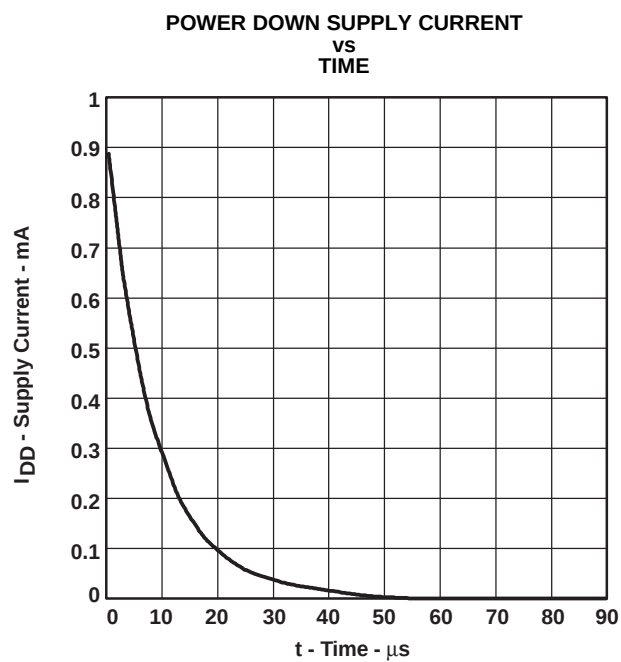


Figure 12.

## APPLICATION INFORMATION

### GENERAL FUNCTION

The TLV5633 is a 12-bit, single supply DAC, based on a resistor string architecture. It consists of a parallel interface, a speed and power down control logic, a programmable internal reference, a resistor string, and a rail-to-rail output buffer. The output voltage (full scale determined by reference) is given by:

$$2 \text{ REF } \frac{\text{CODE}}{0 \times 1000} [\text{V}]$$

Where REF is the reference voltage and CODE is the digital input value in the range 0x000 to 0xFFFF. A power on reset initially puts the internal latches to a defined state (all bits zero).

### PARALLEL INTERFACE

The device latches data on the positive edge of  $\overline{\text{WE}}$ . It must be enabled with  $\overline{\text{CS}}$  low. Whether the data is written to one of the DAC holding latches (MSW, LSW) or the control register depends on the address bits A1 and A0.  $\overline{\text{LDAC}}$  low updates the DAC with the value in the holding latch.  $\overline{\text{LDAC}}$  is an asynchronous input and can be held low, if a separate update is not necessary. However, to control the DAC using the load feature, there should be approximately a 5 ns delay after the positive  $\overline{\text{WE}}$  edge before driving  $\overline{\text{LDAC}}$  low. Two more asynchronous inputs, SPD and  $\overline{\text{PWR}}$  control the settling times and the power-down mode:

SPD: Speed control      1 → fast mode                      0 → slow mode

$\overline{\text{PWR}}$ : Power control      1 → normal operation                      0 → power down

It is also possible to program the different modes (fast, slow, power down) and the DAC update latch using the control register. The following tables list the possible combinations of control signals and control bits.

| PIN | BIT | MODE |
|-----|-----|------|
| SPD | SPD |      |
| 0   | 0   | Slow |
| 0   | 1   | Fast |
| 1   | 0   | Fast |
| 1   | 1   | Fast |

| PIN                     | BIT | POWER  |
|-------------------------|-----|--------|
| $\overline{\text{PWR}}$ | PWD |        |
| 0                       | 0   | Down   |
| 0                       | 1   | Down   |
| 1                       | 0   | Normal |
| 1                       | 1   | Down   |

| PIN                      | BIT   | LATCH       |
|--------------------------|-------|-------------|
| $\overline{\text{LDAC}}$ | RLDAC |             |
| 0                        | 0     | Transparent |
| 0                        | 1     | Transparent |
| 1                        | 0     | Hold        |
| 1                        | 1     | Transparent |

## DATA FORMAT

The TLV5633 writes data either to one of the DAC holding latches or to the control register depending on the address bits A1 and A0.

### ADDRESS BITS

| A1 | A0 | REGISTER        |
|----|----|-----------------|
| 0  | 0  | DAC LSW holding |
| 0  | 1  | DAC MSW holding |
| 1  | 0  | Reserved        |
| 1  | 1  | Control         |

The following table lists the meaning of the bits within the control register.

| D7               | D6               | D5               | D4               | D3               | D2               | D1               | D0               |
|------------------|------------------|------------------|------------------|------------------|------------------|------------------|------------------|
| X                | X                | X                | REF1             | REF0             | RLDAC            | PWR              | SPD              |
| X <sup>(1)</sup> | X <sup>(1)</sup> | X <sup>(1)</sup> | 0 <sup>(1)</sup> | 0 <sup>(1)</sup> | 0 <sup>(1)</sup> | 0 <sup>(1)</sup> | 0 <sup>(1)</sup> |

(1) Default values: X = Don't Care

SPD: Speed control bit    1 → fast mode            0 → slow mode

PWR: Power control bit    1 → power down            0 → normal operation

RLDAC: Load DAC latch    1 → latch transparent    0 → DAC latch controlled by  $\overline{\text{LDAC}}$  pin

REF1 and REF0 determine the reference source and the reference voltage.

### REFERENCE BITS

| REF1 | REF0 | REFERENCE |
|------|------|-----------|
| 0    | 0    | External  |
| 0    | 1    | 1.024 V   |
| 1    | 0    | 2.048 V   |
| 1    | 1    | External  |

If an external reference voltage is applied to the REF pin, external reference must be selected.

## LAYOUT CONSIDERATIONS

To achieve the best performance, it is recommended to have separate power planes for GND, AV<sub>DD</sub>, and DV<sub>DD</sub>. Figure 13 shows how to lay out the power planes for the TLV5633. As a general rule, digital and analog signals should be separated as wide as possible. To avoid crosstalk, analog and digital traces must not be routed in parallel. The two positive power planes (AV<sub>DD</sub> and DV<sub>DD</sub>) should be connected together at one point with a ferrite bead.

A 100-nF ceramic low series inductance capacitor between DV<sub>DD</sub> and GND and a 1-μF tantalum capacitor between AV<sub>DD</sub> and GND placed as close as possible to the supply pins are recommended for optimal performance.

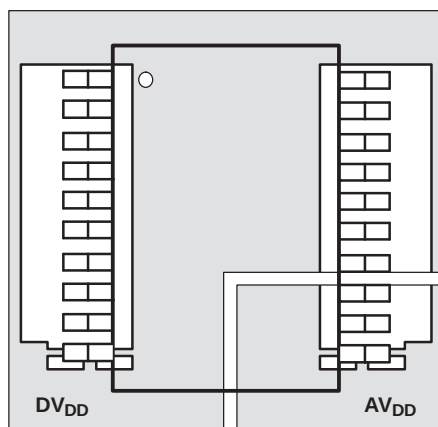


Figure 13. TLV5633 Board Layout

### LINEARITY, OFFSET, AND AGAIN ERROR USING SINGLE END SUPPLIES

When an amplifier is operated from a single supply, the voltage offset can still be either positive or negative. With a positive offset, the output voltage changes on the first code change. With a negative offset the output voltage may not change with the first code, depending on the magnitude of the offset voltage.

The output amplifier attempts to drive the output to a negative voltage. However, because the most negative supply rail is ground, the output cannot drive below ground and clamps the output at 0 V.

The output voltage remains at zero until the input code value produces a sufficient positive output voltage to overcome the negative offset voltage, resulting in the transfer function shown in [Figure 14](#).

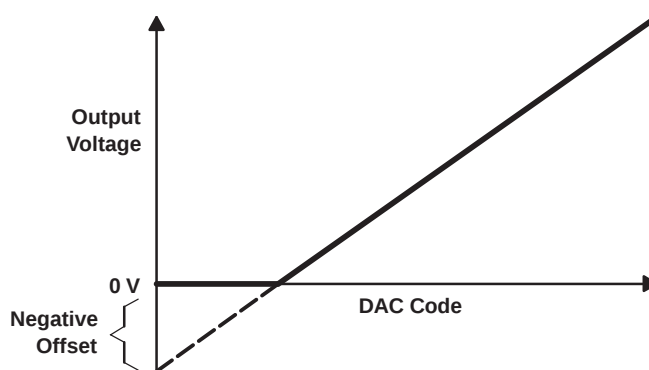


Figure 14. Effect of Negative Offset (Single Supply)

The offset error, not the linearity error, produces this breakpoint. The transfer function would have followed the dotted line if the output buffer could drive below the ground rail.

For a DAC, linearity is measured between zero input code (all inputs 0) and full scale code (all inputs 1) after offset and full scale are adjusted out or accounted for in some way. However, single supply operation does not allow for adjustment when the offset is negative due to the breakpoint in the transfer function. So the linearity is measured between full scale code and the lowest code that produces a positive output voltage.

## TLV5633 INTERFACED to an Intel MCS®51 Controller

The circuit in [Figure 15](#) shows how to interface the TLV5633 to an Intel MCS®51 microcontroller. The address bus and the data bus of the controller are multiplexed on port 0 (non page mode) to save port pins. To separate the address bits and the data bits, the controller provides a dedicated signal, address latch enable (ALE), which is connected to a latch at port 0.

An address decoder is required to generate the chip select signal for the TLV5633. In this example, a simple 3-to-8 decoder (74AC138) is used for the interface as shown in [Figure 15](#). The DAC is memory mapped at addresses 0x8000/1/2/3 within the data memory address space and mirrored every 32 address locations (0x8020/1/2/3, 0x8040/1/2/3, etc.). In a typical microcontroller system, programmable logic should be used to generate the chip select signals for the entire system.

The data pins and the  $\overline{WE}$  pin of the TLV5633 can be connected directly to the multiplexed address and data bus and the  $\overline{WR}$  signal of the controller.

The application uses the TLV5633 device's internal reference at 2.048 V. The  $\overline{LDAC}$  pin is connected to P3.5 and is used to update the DAC after both data bytes have been written.

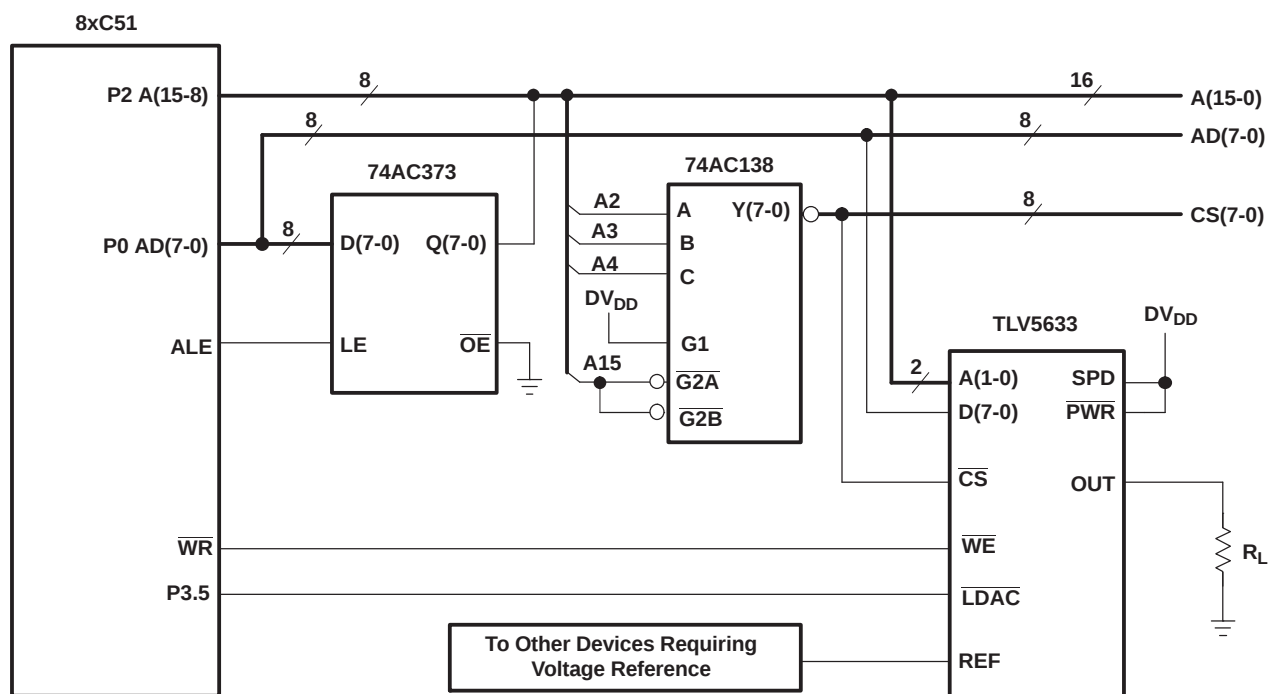


Figure 15. TLV5633 Interfaced to an Intel MCS®51 Controller

## SOFTWARE

In the following example, the code generates a waveform at 20 KSPS with 32 samples stored in a table within the program memory space of the microcontroller.

The waveform data is located in the program memory space at segment SINTBL beginning with the MSW of the first 16-bit word (the 4 MSBs are ignored), followed by the LSW. Two bytes are required for each DAC word (the table is not shown in the code example).

The program consists of two parts:

- A main routine, which is executed after reset and which initializes the timer and the interrupt system of the microcontroller.
- An interrupt service routine, which reads a new value from the waveform table and writes it to the DAC.

```

;-----
; File:      WAVE.A51
; Function:   wave generation with TLV5633
; Processors: 80C51 family (running at 12 MHz)
; Software:   ASM51 assembler, Keil BL51 code-banking linker
; (C) 1999 Texas Instruments
;-----
;-----
; Program function declaration
;-----
NAME      WAVE
MAIN      SEGMENT      CODE
ISR       SEGMENT      CODE
WAVTBL    SEGMENT      CODE
VAR1      SEGMENT      DATA
STACK     SEGMENT      IDATA
;-----
; Code start at address 0, jump to start
;-----
CSEG AT 0
    LJMP start      ; Execution starts at address 0 on power-up.
;-----
; Code in the timer0 interrupt vector
;-----
CSEG AT 0BH
    LJMP timer0ISR  ; Jump vector for timer 0 interrupt is 000Bh
;-----
; Define program variables
;-----
RSEG VAR1
rolling_ptr: DS 1
;-----
; Interrupt service routine for timer 0 interrupts
;-----
RSEG ISR
TIMER0ISR:
    PUSH PSW
    PUSH ACC
    ; The signal to be output on the dac is stored in a table
    ; as 32 samples of msb, lsb pairs (64 bytes).
    ; The pointer, rolling_ptr, rolls round the table of samples
    ; incrementing by 2 bytes (1 sample) on each interrupt
    ; (at the end of this routine).
    MOV DPTR, #wavetable ; set DPTR to the start of the table
    MOV R0, #001H        ; R0 selects DAC MSW
    MOV A,rolling_ptr     ; ACC loaded with the pointer into the wave table
    MOVC A,@A+DPTR        ; get msb from the table
    MOVX @R0, A           ; write DAC MSW
    MOV R0, #000H        ; R0 selects DAC LSW
    MOV A,rolling_ptr     ; move rolling pointer back in to ACC
    INC A                 ; increment ACC holding the rolling pointer
    MOVC A,@A+DPTR        ; which is the lsb of this sample, now in ACC
    MOVX @R0, A           ; write DAC LSW
    MOV A,rolling_ptr     ; load ACC with rolling pointer again
    INC A                 ; increment the ACC twice, to get next sample
    INC A
    ANL A,#003FH          ; wrap back round to 0 if >64
    MOV rolling_ptr,A     ; move value held in ACC back to the rolling pointer

```

```

        CLR    T1                ; set LDACB = 0 (update DAC)
        SETB   T1                ; set LDACB = 1
        POP    ACC
        POP    PSW
        RETI

;-----
; Set up stack
;-----
        RSEG   STACK
        DS 10h    ; 16 Byte Stack!
;-----
; Main Program
;-----
        RSEG   MAIN
start:
        MOV    SP,#STACK-1      ; first set Stack Pointer
        CLR    A
        MOV    rolling_ptr,A    ; set rolling pointer to 0
        MOV    TMOD,#002H       ; set timer 0 to mode 2 - auto-reload
        MOV    TH0,#0CEH        ; set timer 2 re-load value for 20 kHz interrupts
        MOV    P2, #080H        ; set A15 of address bus high to 'memory map'
                                ; device up beyond used address space
        SETB   T1                ; set LDACB = 1 (on P3.5)
                                ; TLV5633 setup
        MOV    R0, #003H        ; R0 selects control register
        MOV    A, #011H         ; LOAD ACC with control register value:
                                ; REF1=1, REF0=0 -> 2.048V internal reference
                                ; RLDAC=0 -> use LDACB pin to control DAC
                                ; PD=0 -> DAC enabled
                                ; SPD=1 -> FAST mode
                                ; write control word:
        MOVX   @R0, A            ; write DAC control word
        SETB   ET0              ; enable timer 0 interrupts
        SETB   EA                ; enable all interrupts
        SETB   TR0              ; start timer 0
always:
        SJMP   always
        RET

;-----
; Table of 32 wave samples used as DAC data
;-----
        RSEG   WAVTBL
wavetable:
;...insert 32 samples here...
.END

```

## DEFINITIONS OF SPECIFICATIONS AND TERMINOLOGY

### **Integral Nonlinearity (INL)**

The relative accuracy or integral nonlinearity (INL), sometimes referred to as linearity error, is the maximum deviation of the output from the line between zero and full scale excluding the effects of zero code and full-scale errors.

### **Differential Nonlinearity (DNL)**

The differential nonlinearity (DNL), sometimes referred to as differential error, is the difference between the measured and ideal 1-LSB amplitude change of any two adjacent codes. Monotonic means the output voltage changes in the same direction (or remains constant) as a change in the digital input code.

### **Zero-Scale Error ( $E_{ZS}$ )**

Zero-scale error is defined as the deviation of the output from 0 V at a digital input value of 0.

### **Gain Error ( $E_G$ )**

Gain error is the error in slope of the DAC transfer function.

### **Signal-To-Noise Ratio + Distortion (SINAD)**

Signal-to-noise ratio + distortion is the ratio of the rms value of the output signal to the rms sum of all other spectral components below the Nyquist frequency, including harmonics but excluding dc. The value for SINAD is expressed in decibels.

### **Spurious Free Dynamic Range (SFDR)**

Spurious free dynamic range is the difference between the rms value of the output signal and the rms value of the spurious signal within a specified bandwidth. The value for SFDR is expressed in decibels.

### **Total Harmonic Distortion (THD)**

Total harmonic distortion is the ratio of the rms sum of the first six harmonic components to the rms value of the fundamental signal and is expressed in decibels.

### Revision history

| Revision | Date    | Description                                                                                                      |
|----------|---------|------------------------------------------------------------------------------------------------------------------|
| A        | 01/2001 | Minor typographical changes.                                                                                     |
| B        | 08/2003 | Changed the High-level and Low-level digital input voltage in the <i>Recommended Operating Conditions</i> table. |
| C        | 09/2006 | Changed the positions of LSW and MSW in <a href="#">Figure 2</a> and <a href="#">Figure 3</a> .                  |

## PACKAGING INFORMATION

| Orderable part number      | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|----------------------------|---------------|----------------------|-----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">TLV5633CDW</a> | Active        | Production           | SOIC (DW)   20  | 25   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | 0 to 70      | TLV5633C            |
| TLV5633CDW.A               | Active        | Production           | SOIC (DW)   20  | 25   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | 0 to 70      | TLV5633C            |
| <a href="#">TLV5633CPW</a> | Active        | Production           | TSSOP (PW)   20 | 70   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | 0 to 70      | TV5633              |
| TLV5633CPW.A               | Active        | Production           | TSSOP (PW)   20 | 70   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | 0 to 70      | TV5633              |
| <a href="#">TLV5633IDW</a> | Active        | Production           | SOIC (DW)   20  | 25   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | TLV5633I            |
| TLV5633IDW.A               | Active        | Production           | SOIC (DW)   20  | 25   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | TLV5633I            |
| <a href="#">TLV5633IPW</a> | Active        | Production           | TSSOP (PW)   20 | 70   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | TY5633              |
| TLV5633IPW.A               | Active        | Production           | TSSOP (PW)   20 | 70   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | TY5633              |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

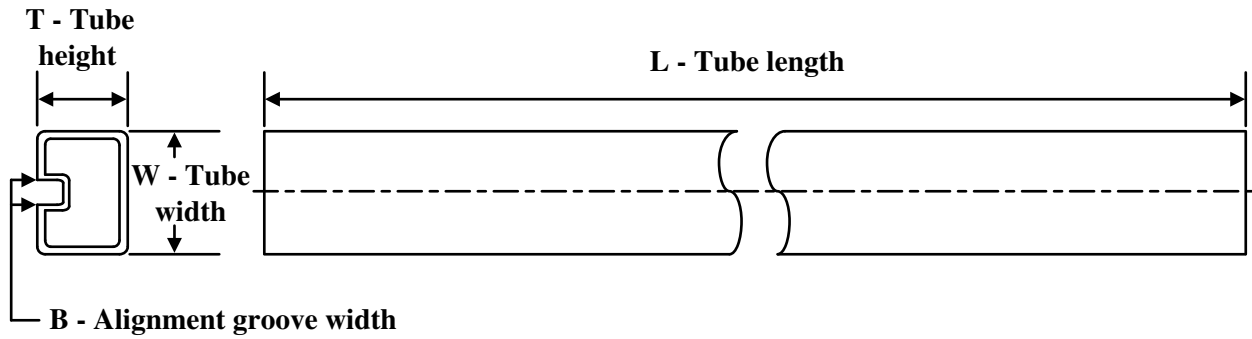
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

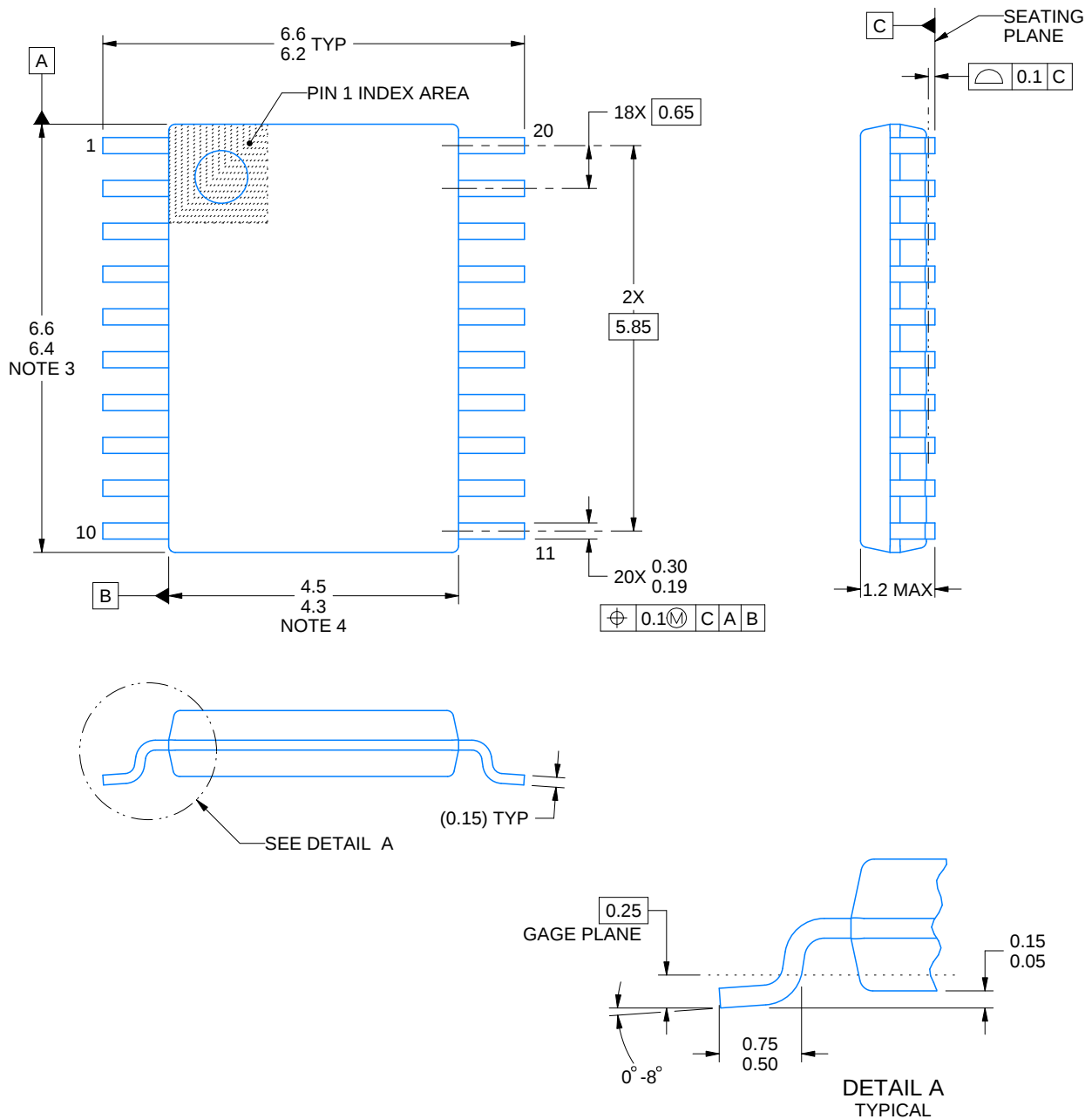
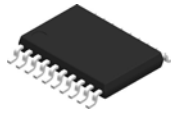
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## TUBE



\*All dimensions are nominal

| Device       | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (μm) | B (mm) |
|--------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| TLV5633CDW   | DW           | SOIC         | 20   | 25  | 506.98 | 12.7   | 4826   | 6.6    |
| TLV5633CDW.A | DW           | SOIC         | 20   | 25  | 506.98 | 12.7   | 4826   | 6.6    |
| TLV5633CPW   | PW           | TSSOP        | 20   | 70  | 530    | 10.2   | 3600   | 3.5    |
| TLV5633CPW.A | PW           | TSSOP        | 20   | 70  | 530    | 10.2   | 3600   | 3.5    |
| TLV5633IDW   | DW           | SOIC         | 20   | 25  | 506.98 | 12.7   | 4826   | 6.6    |
| TLV5633IDW.A | DW           | SOIC         | 20   | 25  | 506.98 | 12.7   | 4826   | 6.6    |
| TLV5633IPW   | PW           | TSSOP        | 20   | 70  | 530    | 10.2   | 3600   | 3.5    |
| TLV5633IPW.A | PW           | TSSOP        | 20   | 70  | 530    | 10.2   | 3600   | 3.5    |



4220206/A 02/2017

## NOTES:

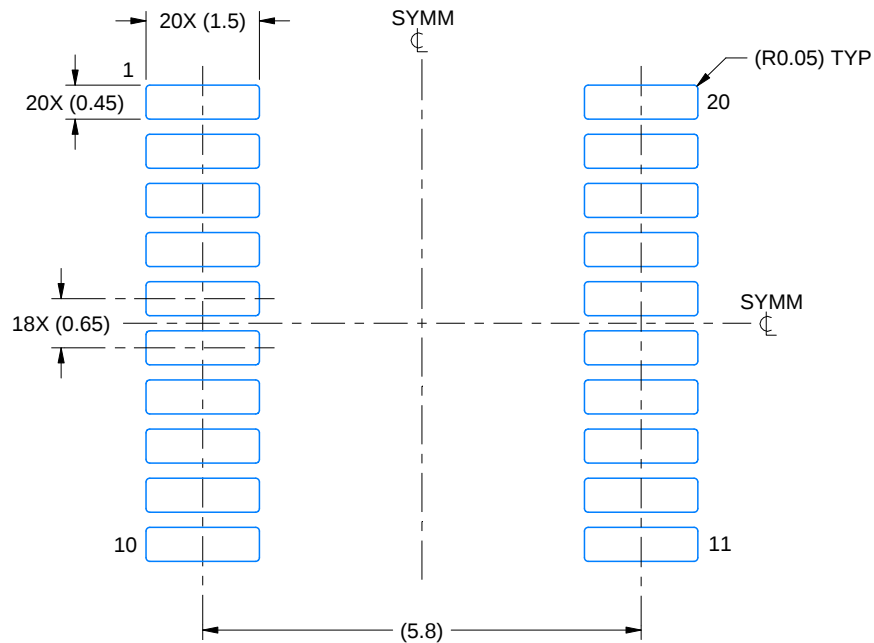
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

# EXAMPLE BOARD LAYOUT

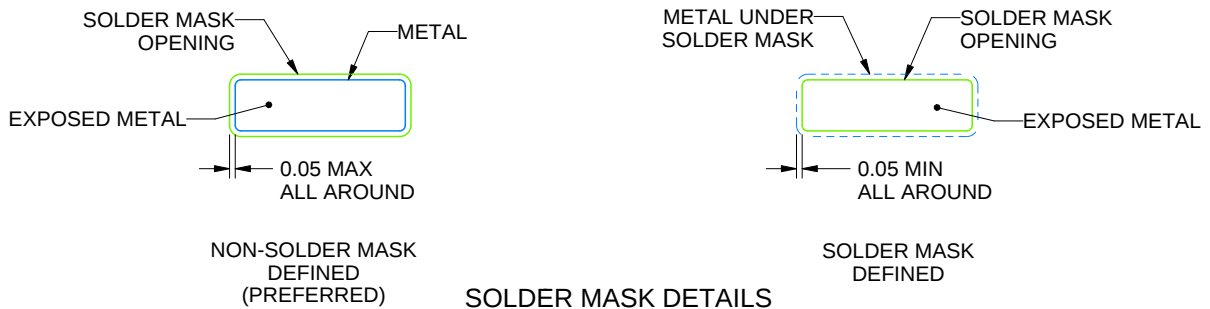
PW0020A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



4220206/A 02/2017

NOTES: (continued)

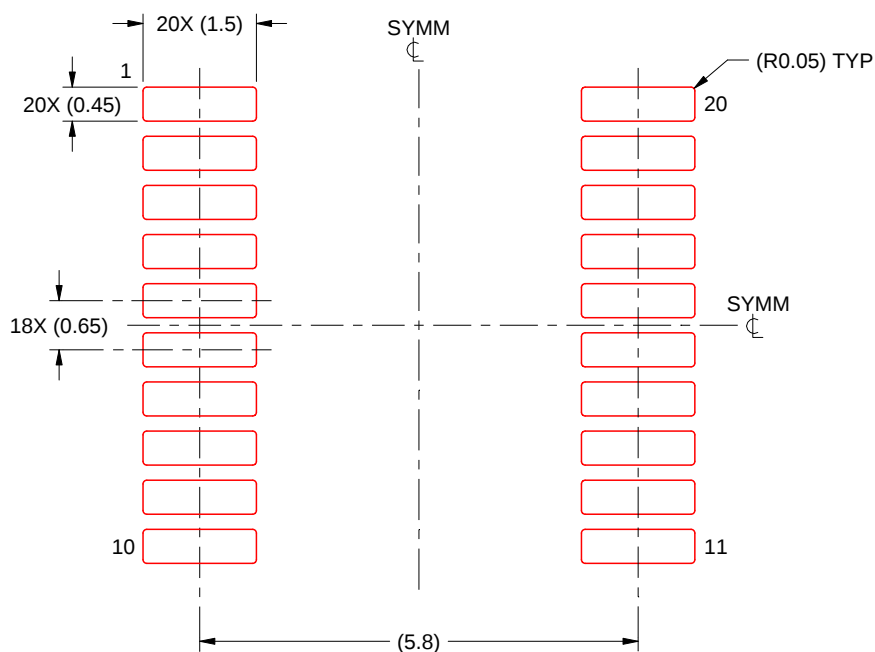
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

PW0020A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

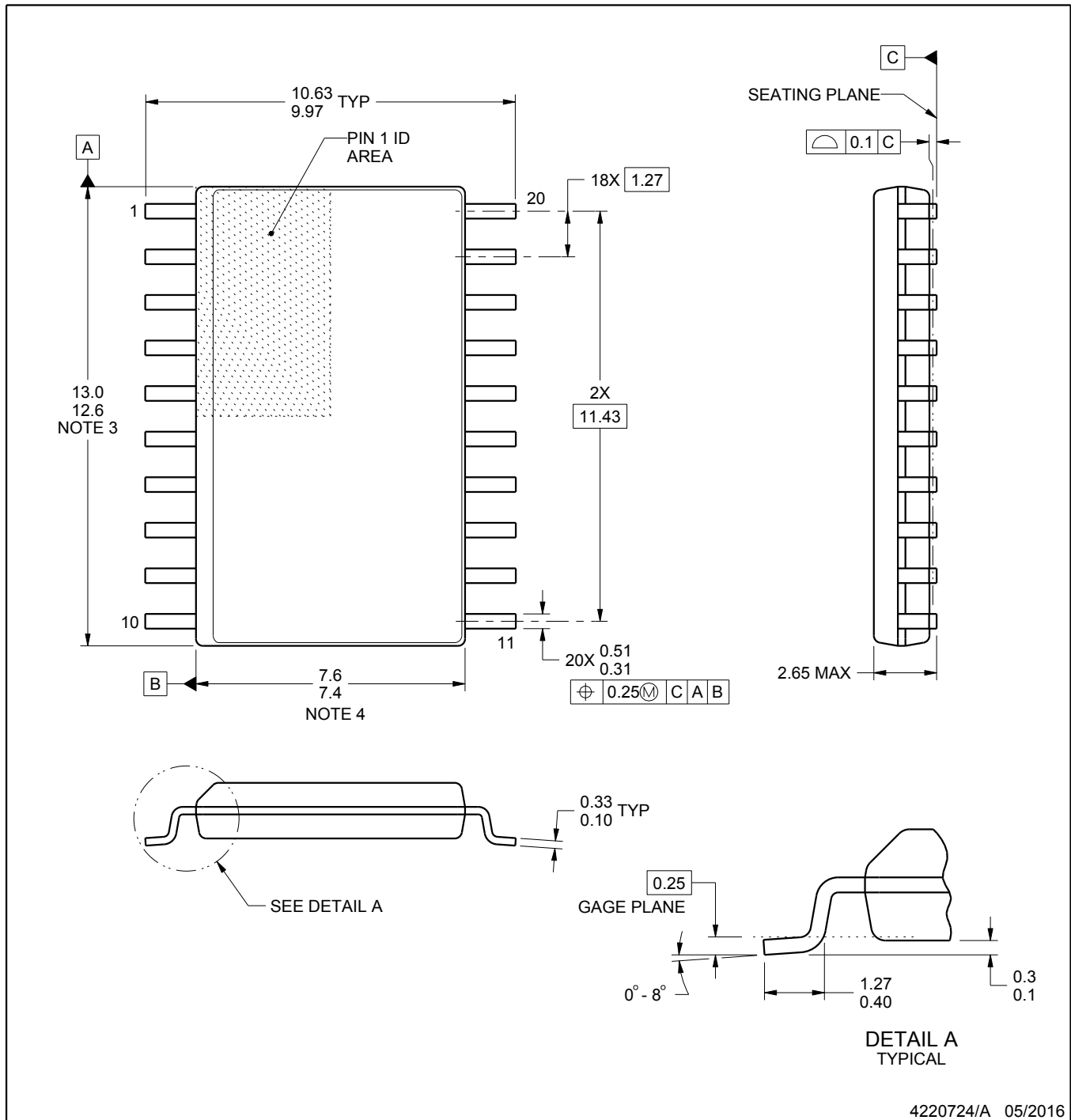


SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

4220206/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



## NOTES:

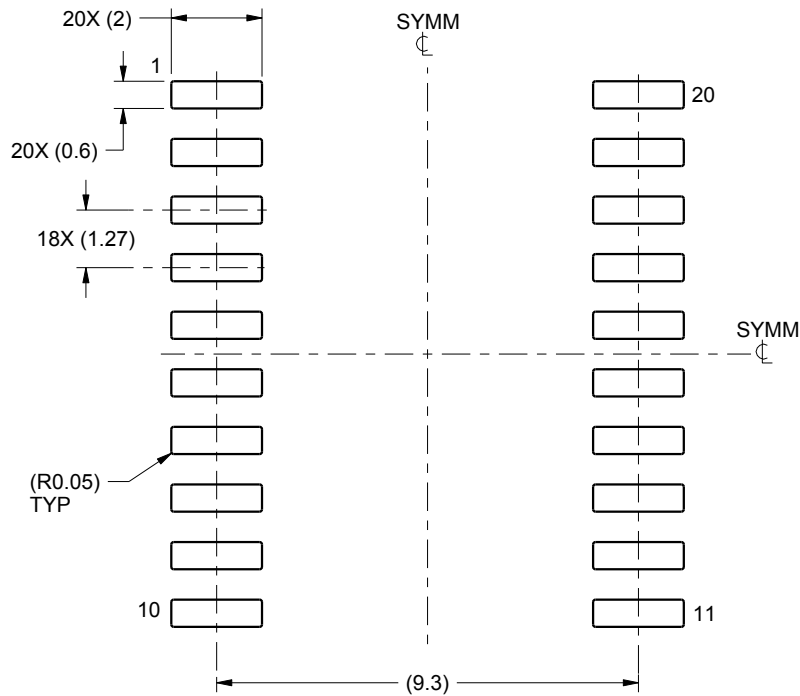
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
5. Reference JEDEC registration MS-013.

# EXAMPLE BOARD LAYOUT

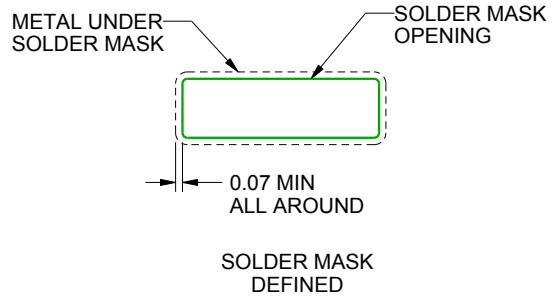
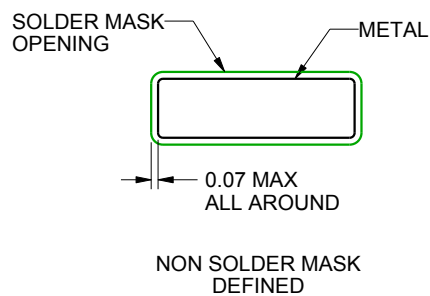
DW0020A

SOIC - 2.65 mm max height

SOIC



LAND PATTERN EXAMPLE  
SCALE:6X



SOLDER MASK DETAILS

4220724/A 05/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

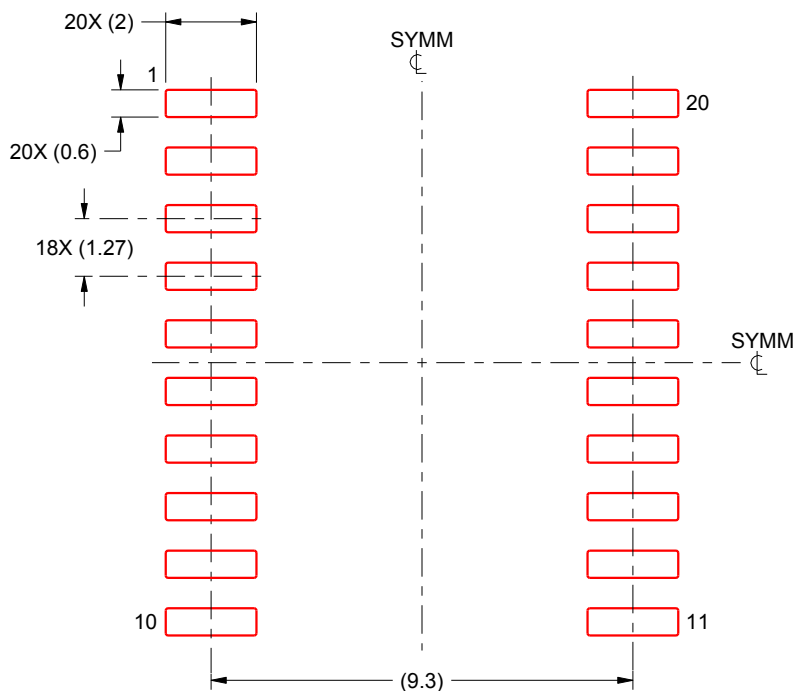
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

DW0020A

SOIC - 2.65 mm max height

SOIC



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:6X

4220724/A 05/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

## IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#), [TI's General Quality Guidelines](#), or other applicable terms available either on [ti.com](#) or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2026, Texas Instruments Incorporated

Last updated 10/2025